

General Description

- Trench Power MOSFET technology
- Low $R_{DS(ON)}$
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

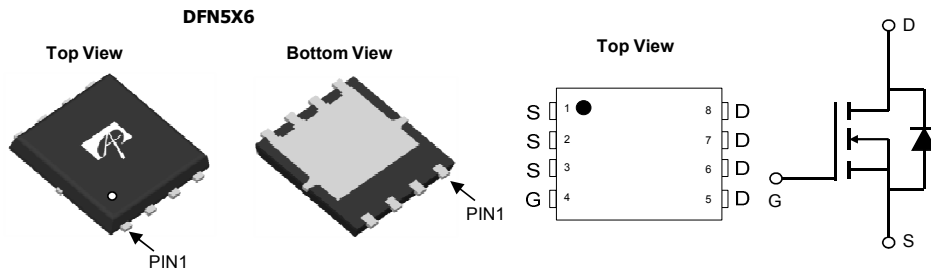
Applications

- DC/DC Converters in Computing
- Isolated DC/DC Converters in Telecom and Industrial
- See Note I

Product Summary

| | |
|----------------------------------|------------------|
| V_{DS} | 30V |
| I_D (at $V_{GS}=10V$) | 130A |
| $R_{DS(ON)}$ (at $V_{GS}=10V$) | < 1.85m Ω |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$) | < 2.5m Ω |

100% UIS Tested
 100% Rg Tested



| Orderable Part Number | Package Type | Form | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AON6312 | DFN 5x6 | Tape & Reel | 3000 |

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|---|----------------|-------------------------|------------------|
| Drain-Source Voltage | V_{DS} | 30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current | I_D | $T_C=25^\circ\text{C}$ | 130 |
| | | $T_C=100^\circ\text{C}$ | 83 |
| Pulsed Drain Current ^C | I_{DM} | 260 | A |
| Continuous Drain Current | I_{DSM} | $T_A=25^\circ\text{C}$ | 46 |
| | | $T_A=70^\circ\text{C}$ | 37 |
| Avalanche Current ^C | I_{AS} | 80 | A |
| Avalanche energy $L=0.01\text{mH}$ ^C | E_{AS} | 32 | mJ |
| V_{DS} Spike | V_{SPIKE} | 36 | V |
| Power Dissipation ^B | P_D | $T_C=25^\circ\text{C}$ | 50 |
| | | $T_C=100^\circ\text{C}$ | 20 |
| Power Dissipation ^A | P_{DSM} | $T_A=25^\circ\text{C}$ | 6.2 |
| | | $T_A=70^\circ\text{C}$ | 4 |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | $^\circ\text{C}$ |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 15 | 20 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient ^{A,D} | | | | |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 1.9 | 2.5 | $^\circ\text{C/W}$ |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|------|-----------|---------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$ | 30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=30\text{V}$, $V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | 1 5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}$, $V_{GS}=\pm 20\text{V}$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$ | 1.3 | 1.75 | 2.2 | V |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}$, $I_D=20\text{A}$ $T_J=125^\circ\text{C}$ | | 1.5 | 1.85 | m Ω |
| | | $V_{GS}=4.5\text{V}$, $I_D=20\text{A}$ | | 2.0 | 2.45 | |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}$, $I_D=20\text{A}$ | | 125 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}$, $V_{GS}=0\text{V}$ | | 0.68 | 1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 60 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}$, $V_{DS}=15\text{V}$, $f=1\text{MHz}$ | | 3100 | | pF |
| C_{oss} | Output Capacitance | | | 875 | | pF |
| C_{riss} | Reverse Transfer Capacitance | | | 105 | | pF |
| R_g | Gate resistance | $f=1\text{MHz}$ | 1.1 | 2.3 | 3.5 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}$, $V_{DS}=15\text{V}$, $I_D=20\text{A}$ | | 43 | 65 | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | | 20 | 30 | nC |
| Q_{gs} | Gate Source Charge | | | 8.5 | | nC |
| Q_{gd} | Gate Drain Charge | | | 6 | | nC |
| $t_{D(on)}$ | Turn-On DelayTime | $V_{GS}=10\text{V}$, $V_{DS}=15\text{V}$, $R_L=0.75\Omega$, $R_{GEN}=3\Omega$ | | 11.5 | | ns |
| t_r | Turn-On Rise Time | | | 5 | | ns |
| $t_{D(off)}$ | Turn-Off DelayTime | | | 40 | | ns |
| t_f | Turn-Off Fall Time | | | 8 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=20\text{A}$, $di/dt=500\text{A}/\mu\text{s}$ | | 17 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=20\text{A}$, $di/dt=500\text{A}/\mu\text{s}$ | | 36 | | nC |

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on $R_{\theta JA} t \leq 10\text{s}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}=150^\circ\text{C}$.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

I. For application requiring slow $>1\text{ms}$ turn-on/turn-off, please consult AOS FAE for proper product selection.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

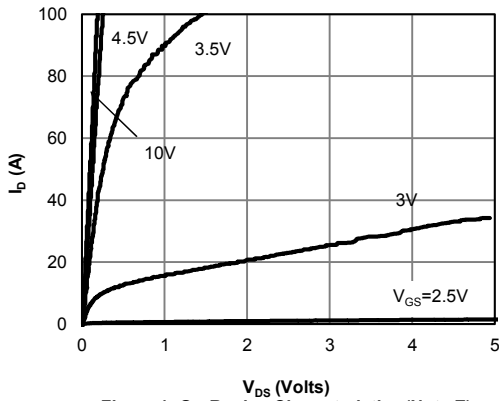


Figure 1: On-Region Characteristics (Note E)

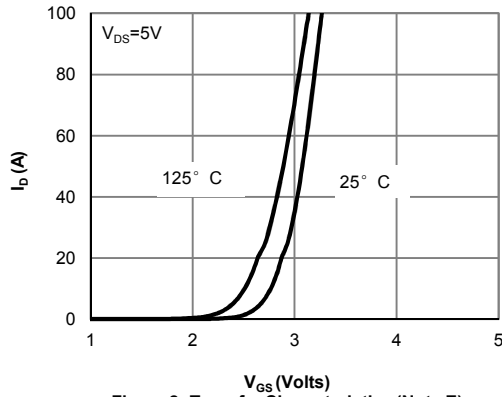


Figure 2: Transfer Characteristics (Note E)

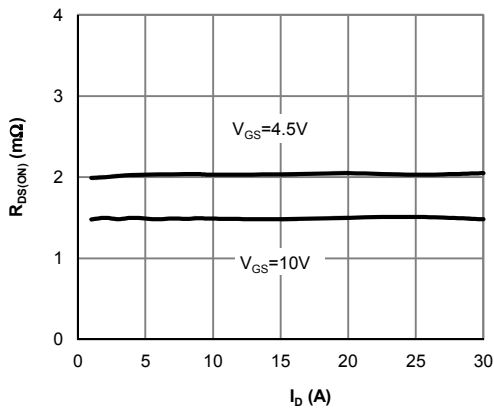


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

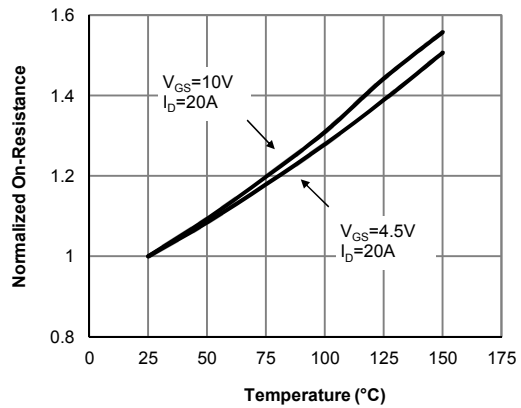


Figure 4: On-Resistance vs. Junction Temperature (Note E)

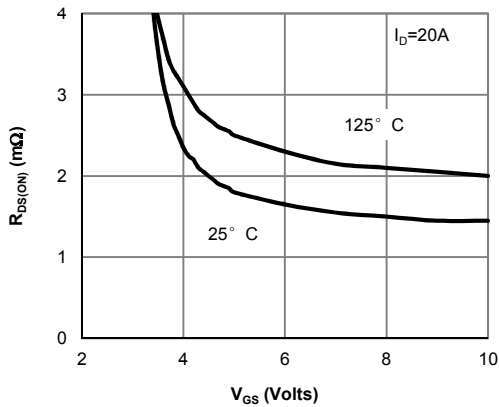


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

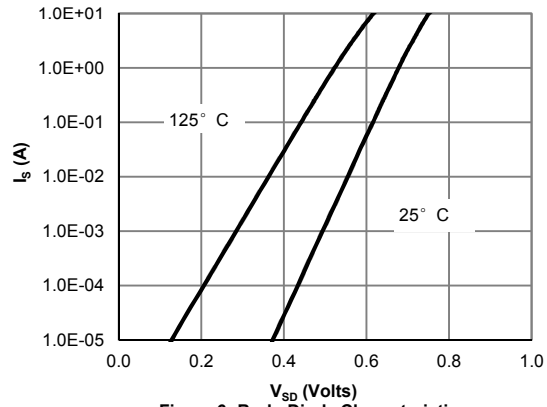


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

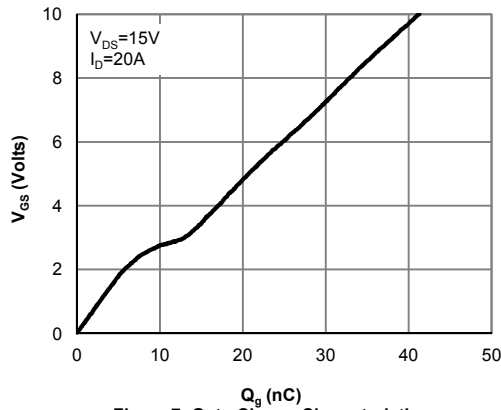


Figure 7: Gate-Charge Characteristics

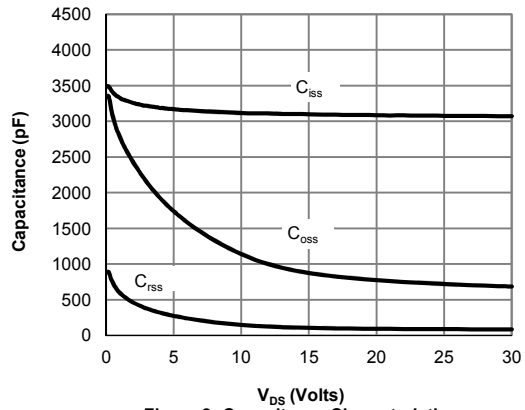


Figure 8: Capacitance Characteristics

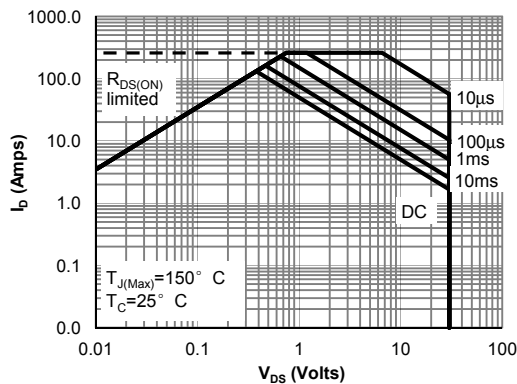


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

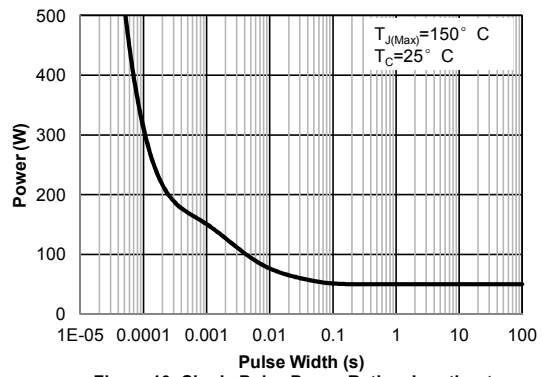


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

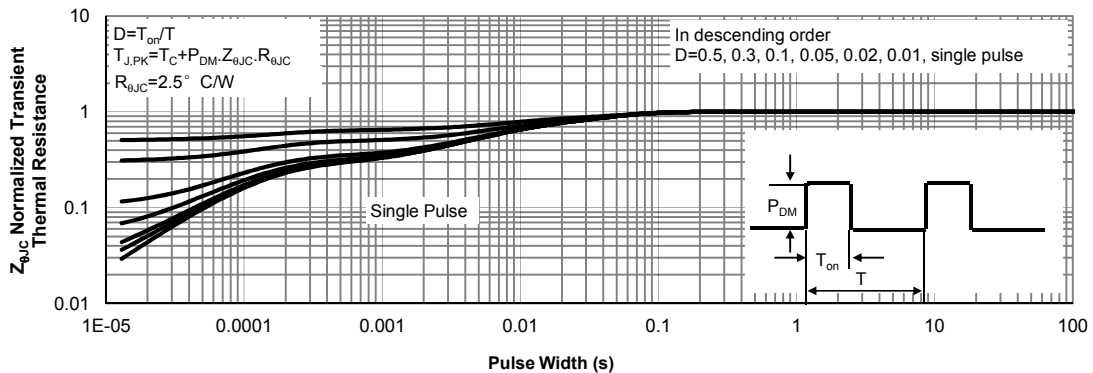


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

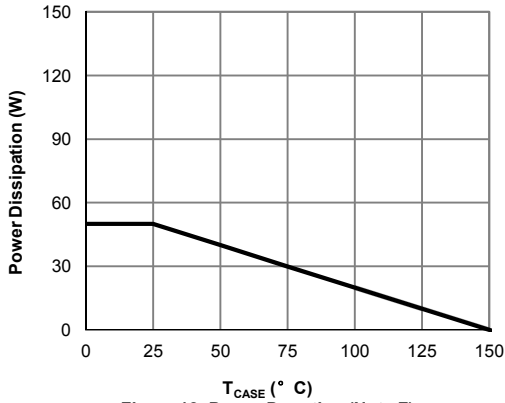


Figure 12: Power De-rating (Note F)

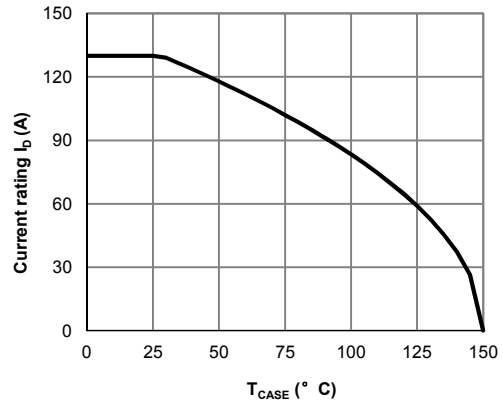


Figure 13: Current De-rating (Note F)

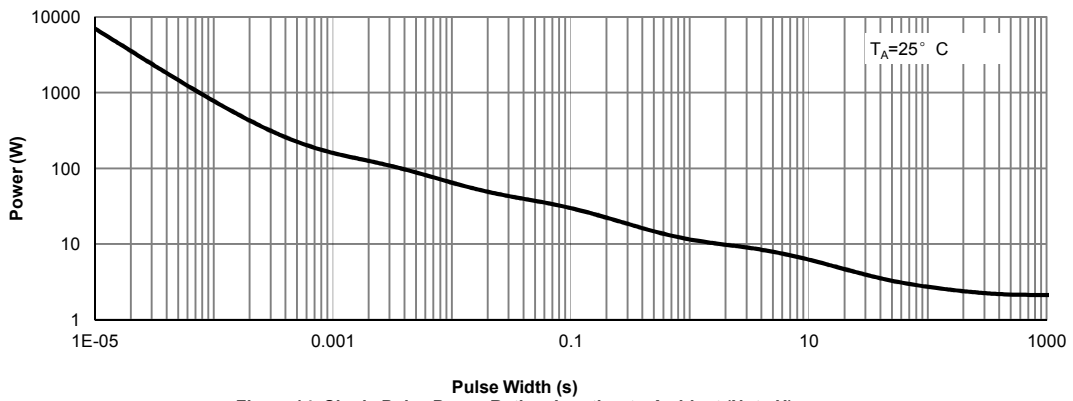


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

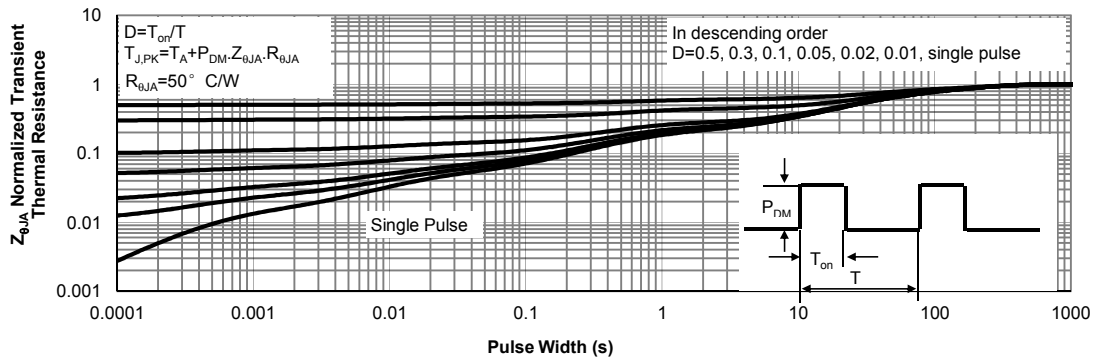


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

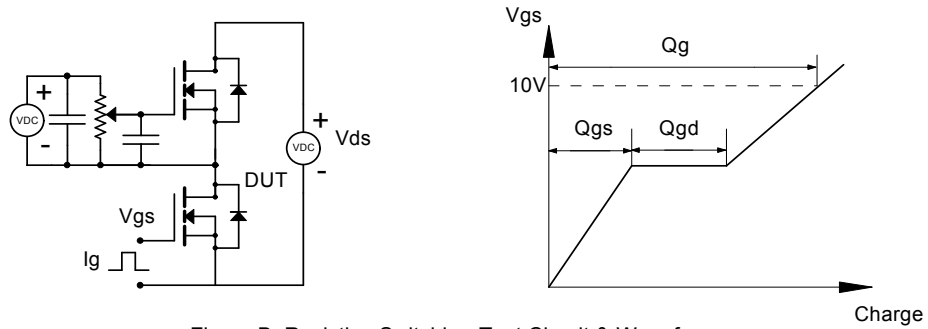


Figure B: Resistive Switching Test Circuit & Waveforms

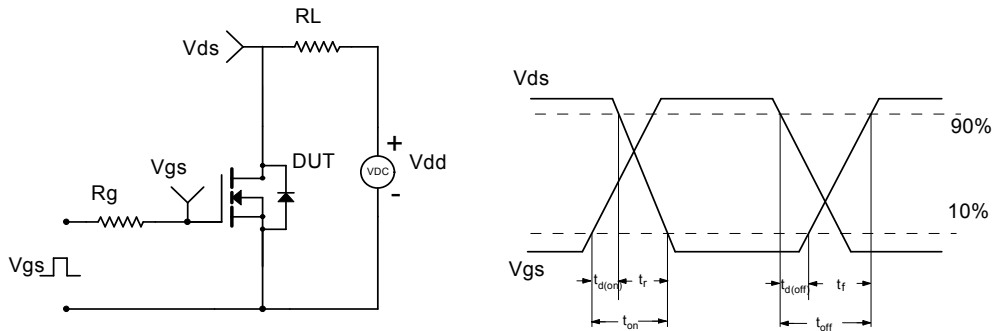


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

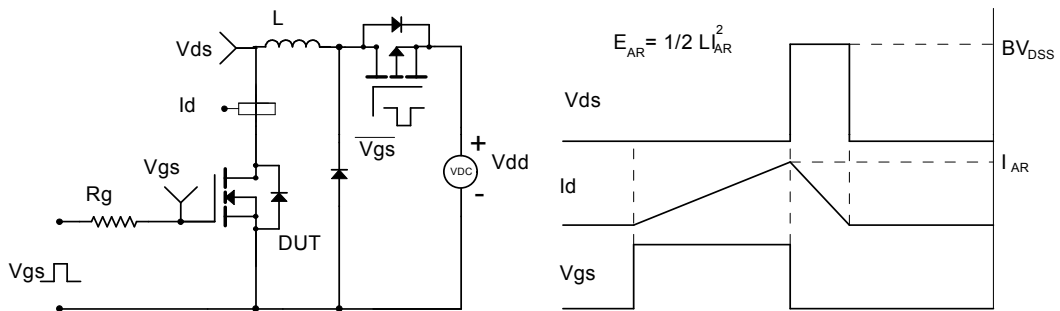


Figure D: Diode Recovery Test Circuit & Waveforms

